

Vishay Siliconix

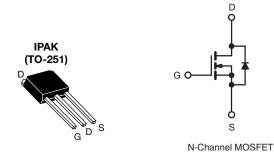
COMPLIANT

HALOGEN

**FREE** 

## **D Series Power MOSFET**

PRODUCT SUMMARY				
V <sub>DS</sub> (V) at T <sub>J</sub> max.	550			
R <sub>DS(on)</sub> max. at 25 °C (Ω)	V <sub>GS</sub> = 10 V	3.2		
Q <sub>g</sub> (max.) (nC)	12			
Q <sub>gs</sub> (nC)	2			
Q <sub>gd</sub> (nC)	3			
Configuration	Single			



#### **FEATURES**

- Optimal design
  - Low area specific on-resistance
  - Low input capacitance (Ciss)
  - Reduced capacitive switching losses
  - High body diode ruggedness
  - Avalanche energy rated (UIS)
- · Optimal efficiency and operation
  - Low cost
  - Simple gate drive circuitry
  - Low figure-of-merit (FOM):  $R_{on} \times Q_g$
  - Fast switching
- Material categorization: For definitions of compliance please see <a href="https://www.vishay.com/doc?99912"><u>www.vishay.com/doc?99912</u></a>

### **APPLICATIONS**

- · Consumer electronics
  - Displays (LCD or plasma TV)
- · Server and telecom power supplies
  - SMPS
- Industrial
  - Welding, induction heating, motor drives
- · Battery chargers

ORDERING INFORMATION	
Package	IPAK (TO-251)
Lead (Pb)-free and Halogen-free	SiHU3N50DA-GE3

ABSOLUTE MAXIMUM RATINGS ( $T_{\mbox{\scriptsize C}}$	= 25 °C, unl	ess otherwis	se noted)		
PARAMETER			SYMBOL	LIMIT	UNIT
Drain-Source Voltage			$V_{DS}$	500	
Gate-Source Voltage				± 30	V
Gate-Source Voltage AC (f > 1 Hz)			$V_{GS}$	30	
Continuous Drain Current (T <sub>J</sub> = 150 °C)	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 25 °C	- I <sub>D</sub>	3.0	
		T <sub>C</sub> = 100 °C		1.9	Α
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	5.5	
Linear Derating Factor				0.56	W/°C
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	9	mJ
Maximum Power Dissipation			$P_{D}$	69	W
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C	
Drain-Source Voltage Slope	T <sub>J</sub> = 125 °C		dV/dt	24	V/ns
Reverse Diode dV/dt <sup>d</sup>		αν/αι	0.22	V/IIS	
Soldering Recommendations (Peak Temperature)c	for 10 s			300	°C

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature.
- b.  $V_{DD}$  = 50 V, starting  $T_J$  = 25 °C, L = 2.3 mH,  $R_g$  = 25  $\Omega$ ,  $I_{AS}$  = 2.8 A.
- c. 1.6 mm from case.
- d.  $I_{SD} \le I_D$ , starting  $T_J = 25$  °C.



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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	62	°C/W	
Maximum Junction-to-Case (Drain)	$R_{thJC}$	-	1.8	C/VV	

PARAMETER	SYMBOL	TES	T CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static				L	L	L	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		500	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	Reference to 25 °C, I <sub>D</sub> = 1 mA		0.59	-	V/°C
Gate-Source Threshold Voltage (N)	V <sub>GS(th)</sub>	V <sub>DS</sub> =	· V <sub>GS</sub> , I <sub>D</sub> = 250 μA	3	-	4.5	V
Gate-Source Leakage	I <sub>GSS</sub>	,	V <sub>GS</sub> = ± 30 V		-	± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>		V <sub>DS</sub> = 500 V, V <sub>GS</sub> = 0 V V <sub>DS</sub> = 400 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C		-	1 10	μΑ
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V		-	2.6	3.2	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub>	= 8 V, I <sub>D</sub> = 1.5 A		1	-	S
Dynamic				L	L	l	
Input Capacitance	C <sub>iss</sub>	$V_{GS} = 0 V$ ,		-	177	-	_
Output Capacitance	Coss	1	$V_{DS} = 100 \text{ V},$		26	-	
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1 MHz		-	7	-	
Effective Output Capacitance, Energy Related <sup>b</sup>	C <sub>o(er)</sub>	$V_{DS} = 0 V \text{ to } 400 V, V_{GS} = 0 V$		-	21	-	pF
Effective Output Capacitance, Time Related <sup>c</sup>	C <sub>o(tr)</sub>			-	28	-	
Total Gate Charge	$Q_g$			-	6	12	
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V	$V_{GS} = 10 \text{ V}$ $I_{D} = 1.5 \text{ A}, V_{DS} = 400 \text{ V}$		2	-	nC
Gate-Drain Charge	Q <sub>gd</sub>			-	3	-	
Turn-On Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> = 400 V, I <sub>D</sub> = 1.5 A		-	12	24	
Rise Time	t <sub>r</sub>			-	9	18	no
Turn-Off Delay Time	t <sub>d(off)</sub>	$R_g =$	$R_g = 9.1 \Omega, V_{GS} = 10 V$		11	22	ns
Fall Time	t <sub>f</sub>	<u> </u>		-	13	26	
Gate Input Resistance	$R_{g}$	f = 1 MHz, open drain		-	2.6	-	Ω
<b>Drain-Source Body Diode Characteristic</b>	s						
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse P - N junction diode		-	-	3	
Pulsed Diode Forward Current	I <sub>SM</sub>			-	-	5.5	A
Diode Forward Voltage	$V_{SD}$	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 1.5 A, V <sub>GS</sub> = 0 V		-	-	1.2	V
Reverse Recovery Time	t <sub>rr</sub>	$T_J = 25 ^{\circ}\text{C}$ , $I_F = I_S = 1.5 \text{A}$ , $dI/dt = 100 \text{A/}\mu\text{s}$ , $V_R = 25 \text{V}$		-	285	570	ns
Reverse Recovery Charge	$Q_{rr}$			-	0.68	1.36	μC
Reverse Recovery Current	I <sub>RRM</sub>			_	5	-	Α

#### Notes

- a.  $C_{oss(er)}$  is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ .
- b.  $C_{oss(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ .



### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

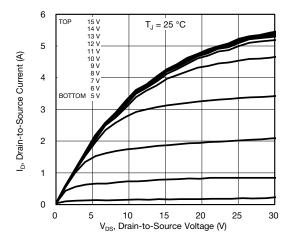


Fig. 1 - Typical Output Characteristics

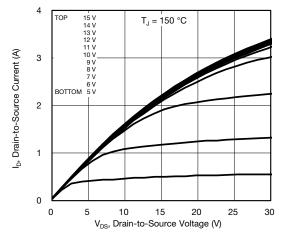


Fig. 2 - Typical Output Characteristics

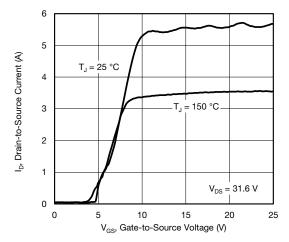


Fig. 3 - Typical Transfer Characteristics

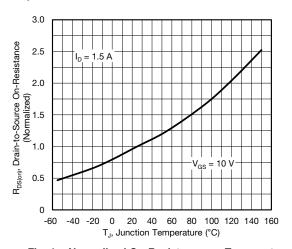


Fig. 4 - Normalized On-Resistance vs. Temperature

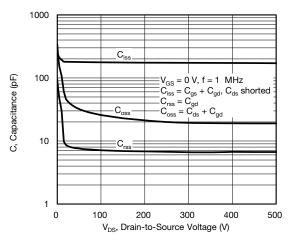


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

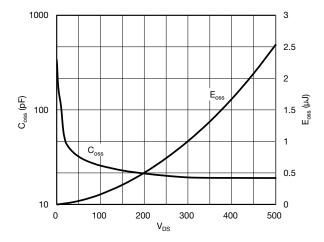


Fig. 6 -  $C_{oss}$  and  $E_{oss}$  vs.  $V_{DS}$ 



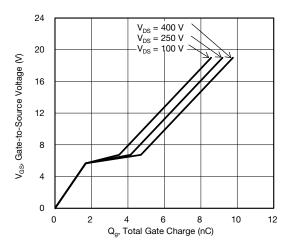


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

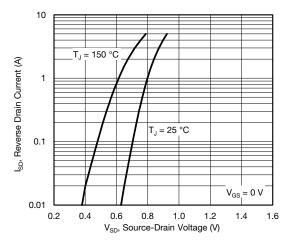


Fig. 8 - Typical Source-Drain Diode Forward Voltage

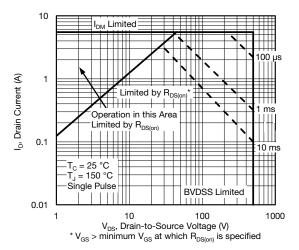


Fig. 9 - Maximum Safe Operating Area

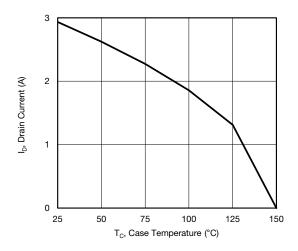


Fig. 10 - Maximum Drain Current vs. Case Temperature

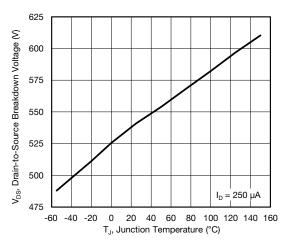


Fig. 11 - Typical Drain-to-Source Voltage vs. Temperature



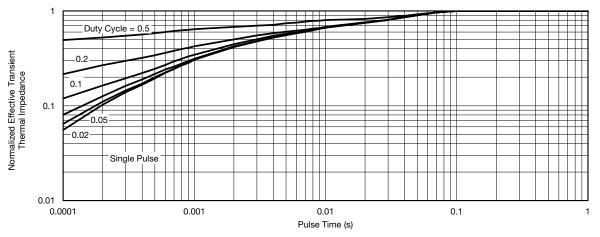


Fig. 12 - Normalized Thermal Transient Impedance, Junction-to-Case

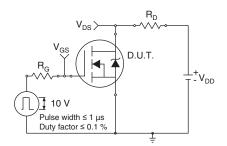


Fig. 13 - Switching Time Test Circuit

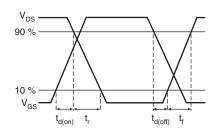


Fig. 14 - Switching Time Waveforms

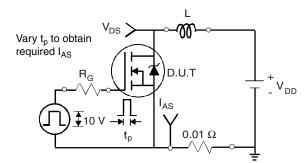


Fig. 15 - Unclamped Inductive Test Circuit

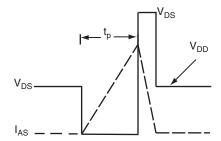


Fig. 16 - Unclamped Inductive Waveforms

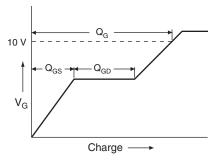


Fig. 17 - Basic Gate Charge Waveform

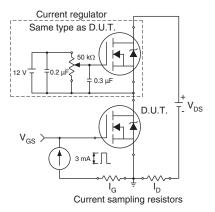
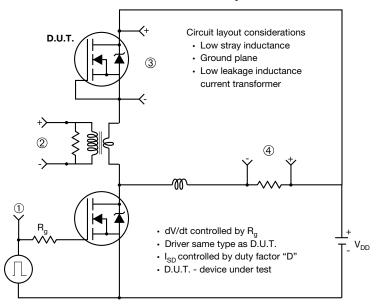


Fig. 18 - Gate Charge Test Circuit



#### Peak Diode Recovery dV/dt Test Circuit



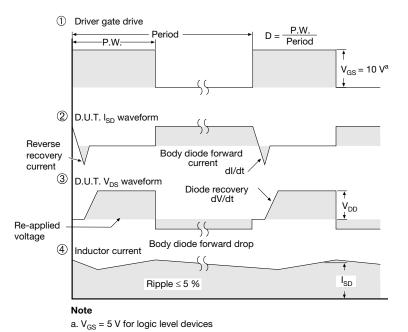


Fig. 19 - For N-Channel

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Vishay

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